

20V P-Channel Enhancement Mode MOSFET

Description

The PECN2301AVR uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V. This device is suitable for use as a load switch or in PWM applications.

General Features

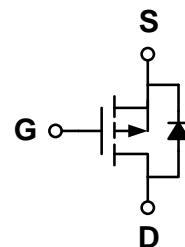
- ◆ $V_{DS} = -20V$, $I_D = -2.8A$
 $R_{DS(ON)}(\text{Typ.}) = 79m\Omega$ @ $V_{GS} = -2.5V$
 $R_{DS(ON)}(\text{Typ.}) = 64m\Omega$ @ $V_{GS} = -4.5V$
- ◆ High power and current handling capability
- ◆ Lead free product is acquired
- ◆ Surface mount package

Application

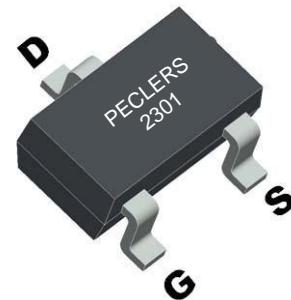
- ◆ PWM applications
- ◆ Load switch

Package

- ◆ SOT-23

**Schematic diagram****Marking and pin assignment**

SOT-23
(Topview)

**Ordering Information**

Part Number	Storage Temperature	Package	Devices Per Reel
PECN2301AVR	-55°C to +150°C	SOT-23	3000

Absolute Maximum Ratings (TA=25°C unless otherwise noted)

parameter	symbol	limit	unit
Drain-source voltage	V_{DS}	-20	V
Gate-source voltage	V_{GS}	± 12	V
Drain current-continuous ^a @Tj=125°C -pulse d ^b	I_D	-2.8	A
	I_{DM}	-11	A
Drain-source Diode forward current	I_S	-1.25	A
Maximum power dissipation	P_D	1	W
Operating junction Temperature range	Tj	-55—150	°C

Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF Characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0V, I _D =-250μA	-20	-	-	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =-20V, V _{GS} =0V	-	-	-1	μA
Gate-body leakage	I _{GSS}	V _{DS} =0V, V _{GS} =±12V	-	-	±100	nA
ON Characteristics						
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250μA	-0.4	-0.65	-1.2	V
Drain-source on-state resistance	R _{DS(ON)}	V _{GS} =-4.5V, I _D =-2.8A	-	64	90	mΩ
		V _{GS} =-2.5V, I _D =-2.8A	-	79	120	
Forward transconductance	g _f	V _{GS} =-5V, I _D =-5A	-	5	-	S
Dynamic Characteristics						
Input capacitance	C _{ISS}	V _{DS} =-10V, V _{GS} =0V f=1.0MHz	-	561	-	pF
Output capacitance	C _{OSS}		-	61	-	
Reverse transfer capacitance	C _{RSS}		-	52	-	
Switching Characteristics						
Turn-on delay time	t _{D(ON)}	V _{DD} =-10V I _D =-2.8A V _{GEN} =-4.5V R _L =10ohm R _{GEN} =-60ohm	-	12.5	-	ns
Rise time	tr		-	6.6	-	
Turn-off delay time	t _{D(OFF)}		-	113	-	
Fall time	tf		-	46.6	-	
Total gate charge	Q _g	V _{DS} =-10V, I _D =-3A V _{GS} =-4.5V	-	6.1	-	nC
Gate-source charge	Q _{gs}		-	1.7	-	
Gate-drain charge	Q _{gd}		-	1.2	-	
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode forward voltage	V _{SD}	V _{GS} =0V, I _s =-1.25A	-	-0.81	-1.2	V

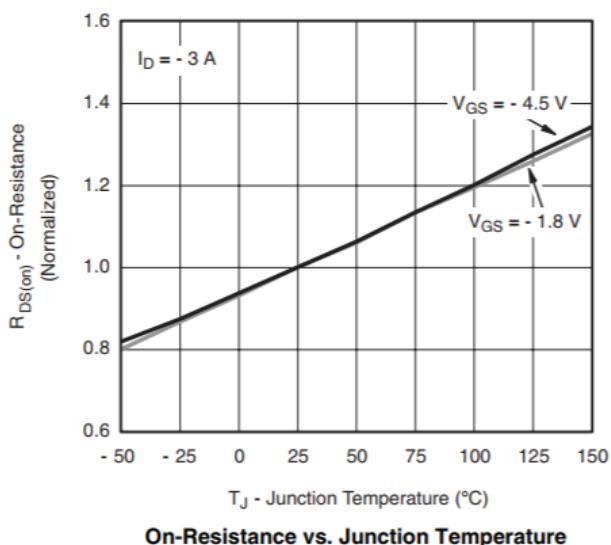
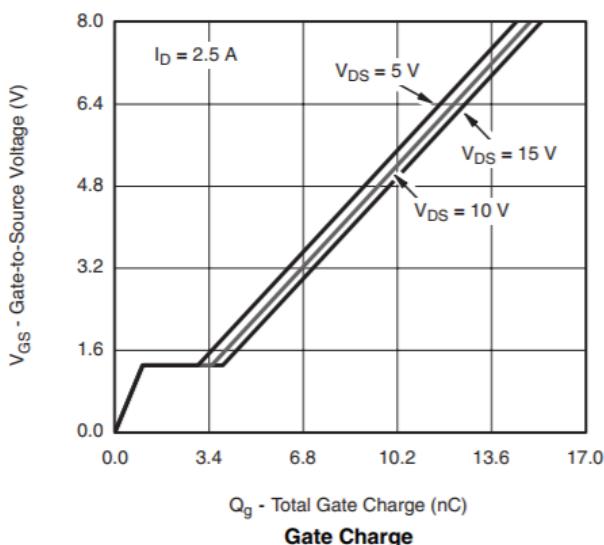
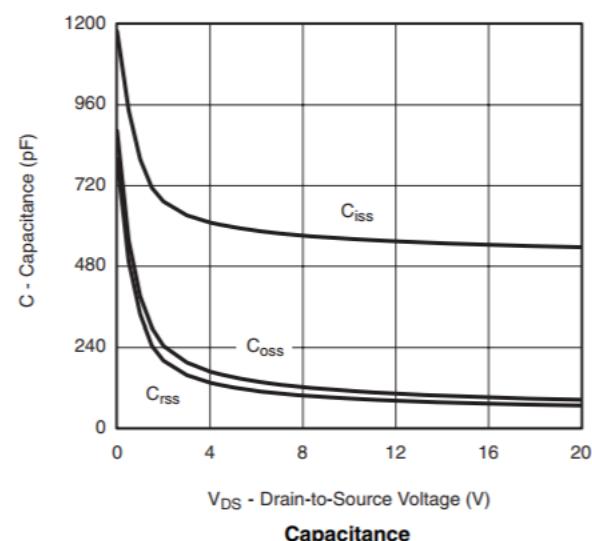
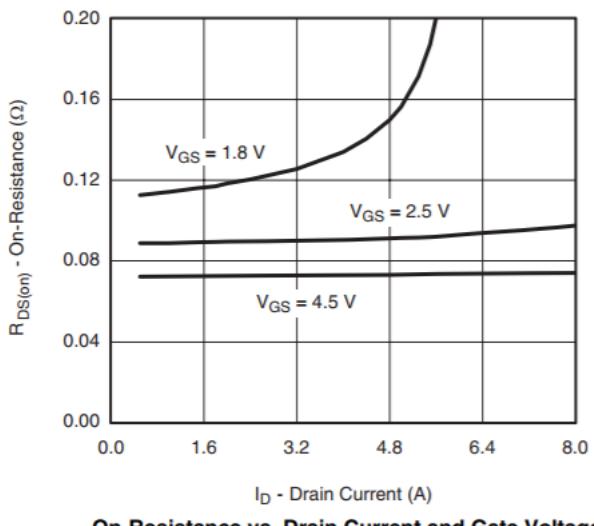
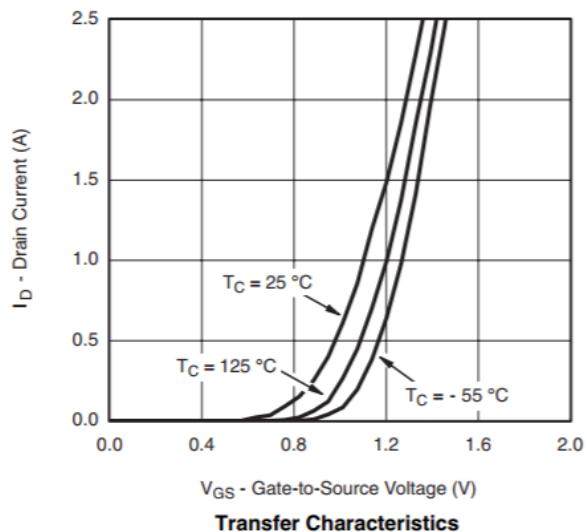
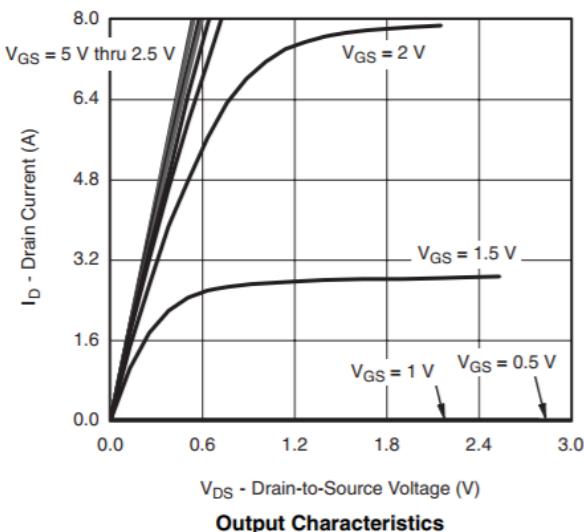
Notes:

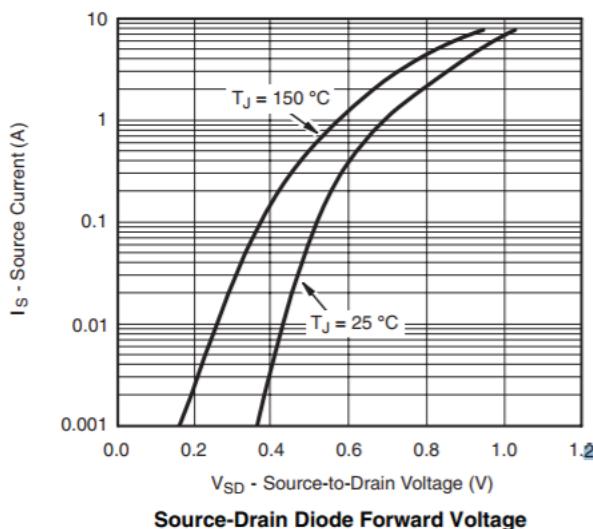
- a. surface mounted on FR4 board, t≤10sec
- b. pulse test: pulse width≤300μs, duty≤2%
- c. guaranteed by design, not subject to production testing

Thermal Characteristics

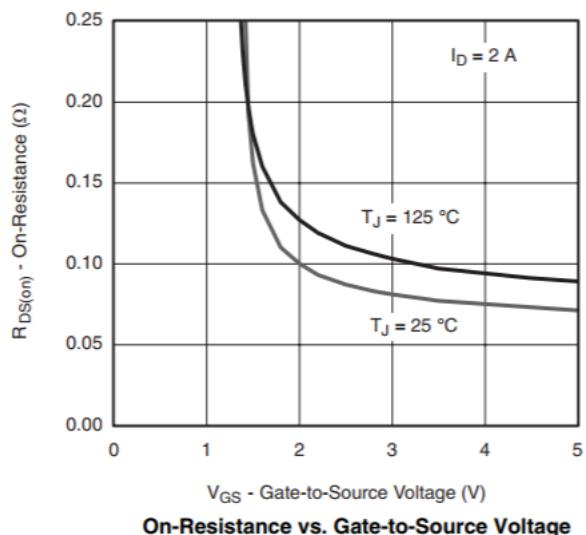
Thermal Resistance junction-to ambient	R _{th JA}	100	°C/W
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Typical Performance Characteristics

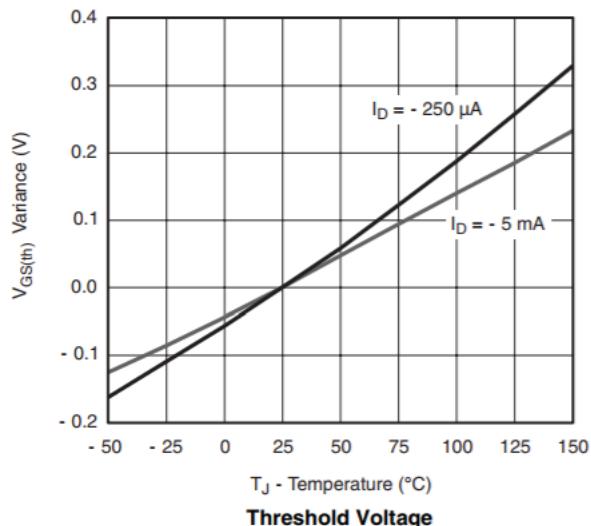




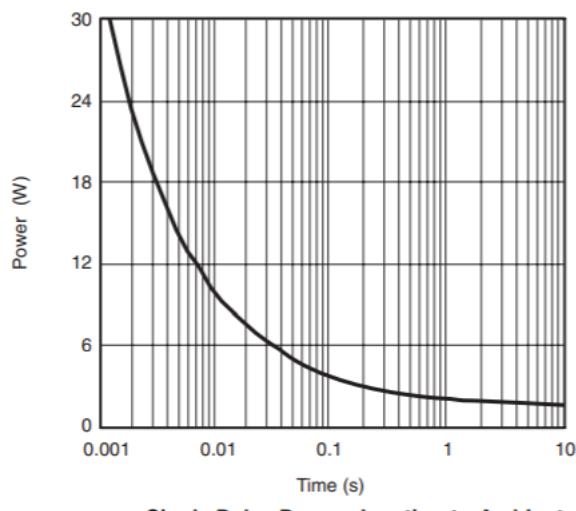
Source-Drain Diode Forward Voltage



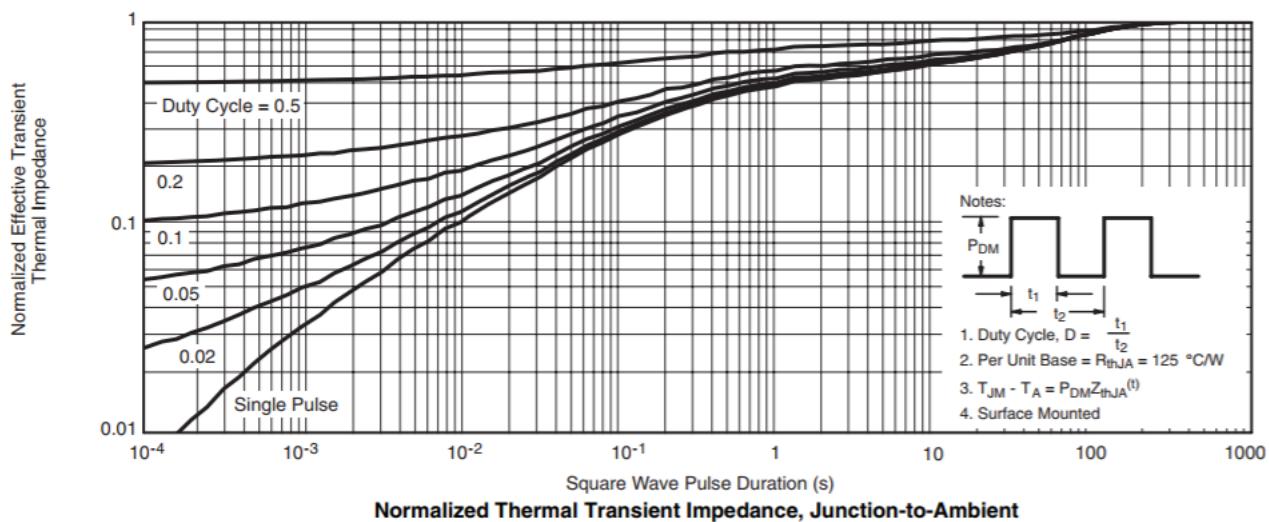
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

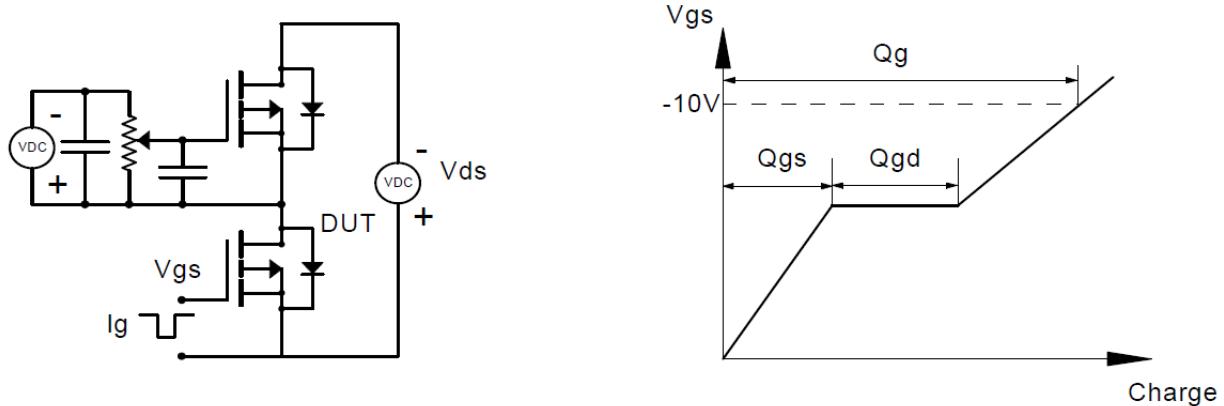


Single Pulse Power, Junction-to-Ambient

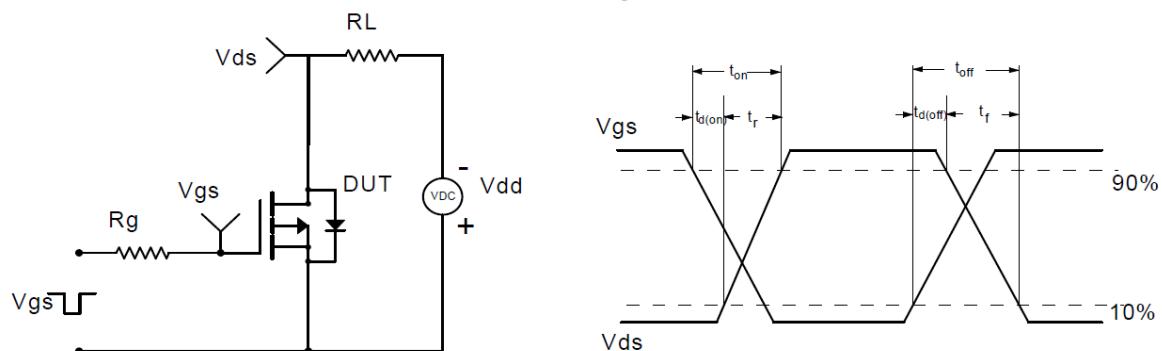


Normalized Thermal Transient Impedance, Junction-to-Ambient

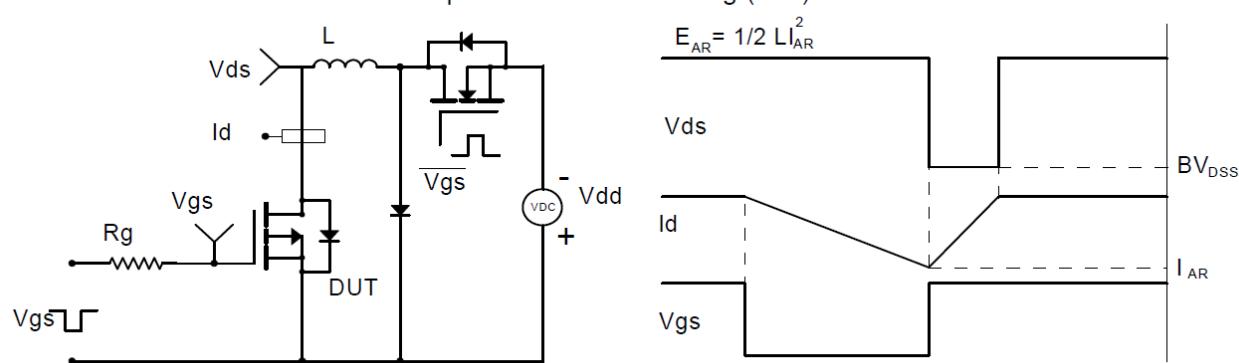
Gate Charge Test Circuit & Waveform



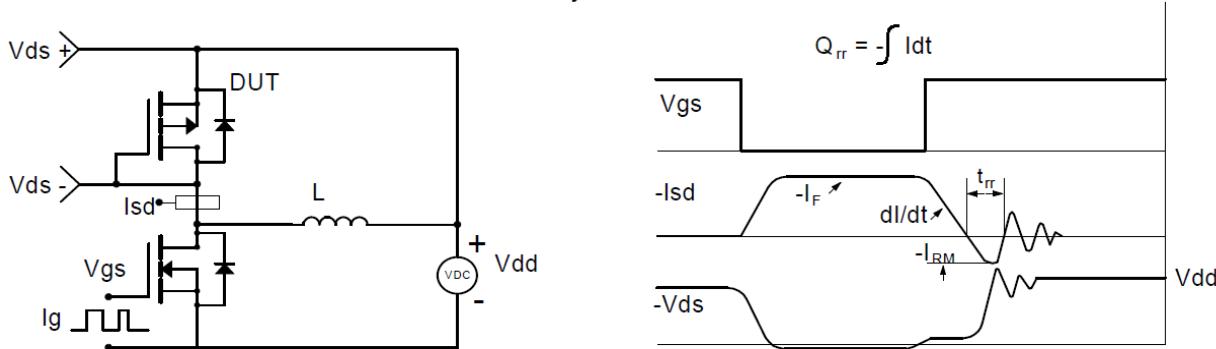
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

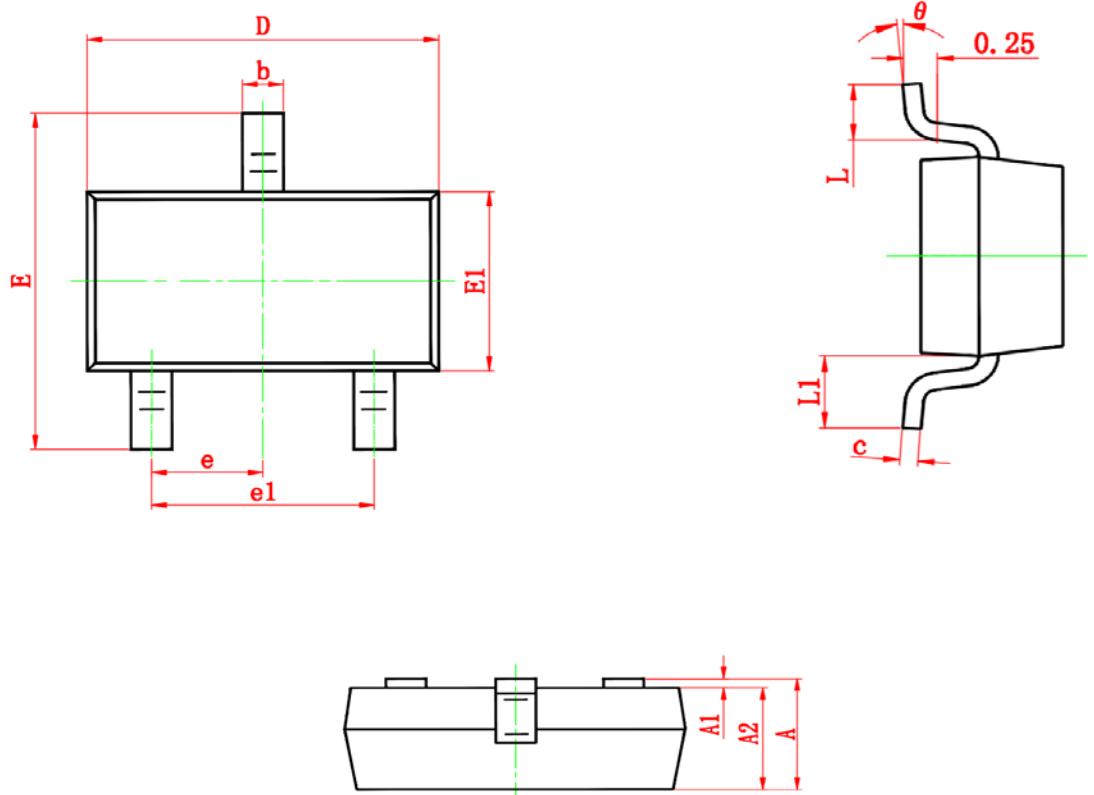


Diode Recovery Test Circuit & Waveforms



Package Information

- SOT-23



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	2.250	2.550	0.089	0.100
E1	1.200	1.400	0.047	0.055
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.300	0.500	0.012	0.020
L1	0.550 REF.		0.022 REF.	
θ	0°	8°	0°	8°